

Notice of References Cited

Application/Control No.

10/654,553

Applicant(s)/Patent Under

Reexamination

HAYASHI ET AL.

Examiner

Drew E. Becker

Art Unit

1761

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,192,636	03-1980	Hayashi et al.	425/96
*	B	US-4,276,317	06-1981	Hayashi, Torahiko	426/501
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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